











E C	Examp lassica	le of e al proba	empirica ability	al	
Find from	the probab the popula	oility of sel ation descr	ecting a ma ibed in the f	le taking st following ta	atistics able:
		Taking Stats	Not Taking Stats	Total	
	Male	84	145	229	1
	Female	76	134	210	1
	Total	160	279	439	1
Probability of	Male Taking	$s \text{Stats} = \frac{\text{num}}{\text{t}}$	ber of males t otal number of	aking stats people =	$\frac{84}{439} = 0.191$

































Generation G	ener kamp	al Add ble	ition Rul	e	
Find the p from the	probabil populati	ity of select on describe	ting a male or a ed in the follow	statistics	student
		Taking Stats	Not Taking Stats	Total	
	Male	84	145	229	
	Female	76	134	210	
	Total	160	279	439	
P(Male	or Stat)	= P(M) + P = 229/439 +	P(S) – P(M or S - 160/439 – 84/) /439 = 30	5/439













Class Exer	rcis	е		
B B' A 10 20 A' 20 40 What is the probability of a. $A \mid B?$ b. $A \mid B'?$ c. $A' \mid B'?$ d. Are avants A and B statistically independent?	table: 4.17	Given the for	bllowing cor B'	ntingency table:
	A A' What a. A b. A' c. A	10 25 is the probat <i>B</i> ? <i>B</i> '? <i>B</i> '?	30 35 bility of	
Statistics for Managers Using Microsoft Excel, 5e $\ensuremath{\mathbb{S}}$ 2008 Pear	d. Ar	e events A ar	nd B statistic	ally independent?







and "Is the waf	found on the die er good or bad?"	that produced t	e wafer'?"	
QUALITY OF	CONI	DITION OF DIE		
WAFER	No Particles	Particles	Totals	
Good	320	14	334	
Bad	80	36	116	
Totals	400	50	450	
Source: Extracted Semiconductor We of Environmental	fom S. W. Hall, "An a firs by Contingency Sciences, Vol. 1, 199	alysis of Defectivi Table," Proceedin 4, pp. 177–183.	y of s Institute	
 a. Suppose you ability that it 	how that a wafe was produced fro	r is bad. What i om a die that had	the prob- particles?	
b. Suppose you ability that it	know that a wafer was produced fro	r is good. What i m a die that had	the prob- particles?	
c. Are the two ticles, statist	events, a good wa ically independent	efer and a die w t? Explain.	th no par-	
	and "Is the waft QUALITY OF WAFER Good Bad Totals Source: Extracted Semiconductor W of Environmental a. Suppose you ability that it b. Suppose you ability that it c. Are the two ticles, statist	and "Is the wafer good or bad?" QUALITY OF WAFER No Particles Good 320 Bad 80 Totals 400 Source: Extracted from S. W. Hall, "An Semiconductor Wa Frs by Contingency of Environmental Sciences, Vol. 1, 199 a. Suppose you know that a wafe ability that it was produced fre b. Suppose you know that a wafe ability that it was produced fre b. Suppose you know that a wafe ability that it was produced fre b. Suppose you know that a wafe ability that it was produced fre b. Suppose you know that a wafe ability that it was produced fre b. Suppose you know that a wafe ability that it was produced fre b. Suppose you know that a wafe ability that it was produced fre b. Suppose you know that a wafe ability that it was produced fre b. Suppose you know that a wafe ability that it was produced fre b. Suppose you know that a wafe ability that it was produced fre b. Suppose you know that a wafe ability that it was produced fre b. Suppose you know that a wafe ability that it was produced fre b. Suppose you know that a wafe ability that it was produced fre b. Suppose you know that a wafe ability that it was produced fre b. Suppose you know that a wafe ability that it was produced fre b. Suppose you know that a wafe ability that it was produced fre b. Suppose you know that a wafe ability that it was produced fre b. Suppose you know that a wafe ability that it was produced fre b. Suppose you know that a wafe ability that it was produced fre b. Suppose you know that a wafe ability that it was produced fre b. Suppose you know that a wafe ability that it was produced fre b. Suppose you know that a wafe ability that it was produced fre b. Suppose you know that a wafe ability that it was produced fre b. Suppose you know that a wafe ability that it was produced fre b. Suppose you know that a wafe ability that it was produced fre b. Suppose you know that a wafe ability that it was produced fre b. Suppose you know that a wafe ability that it was produced fre b. Suppose you know that a wafe ability that it was produced fre b. Suppose you know t	and "is the wafer good or bad?" QUALITY OF WAFER CONDITION OF DIE WAFER No Particles Particles Good 320 14 Bad 80 36 Totals 400 50 Source: Extracted form 5. W. Hall, "Analysis of De fettivit Semiconductor Wa first by Contingency Table," Proceeding of Environmental Sciences, Vol. 1, 1994, pp. 177–183. a. Suppose you know that a wafer is bad. What is ability that it was produced from a die that had b. Suppose you know that a wafer is good. What is ability that it was produced from a die that had c. Are the two events, a good wafer and a die wi ticles, statistically independent? Explain.	and "Is the wafer good or bad?" QUALITY OF CONDITION OF DIE WAFER NO Particles Particles Totals Good 320 14 334 Bad 80 36 116 Totals 400 50 450 Source: Extracted from S. W. Hall, "Analysis of Defetivity of Semiconductor Wa firs by Contingency Table," Proceedings Institute of Environmental Sciences, Vol. 1, 1994, pp. 177–183. a. Suppose you know that a wafer is bad. What is the prob- ability that it was produced from a die that had particles? b. Suppose you know that a wafer is good. What is the prob- ability that it was produced from a die that had particles? c. Are the two events, a good wafer and a die with no par- ticles, statistically independent? Explain.